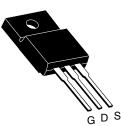
**Vishay Siliconix** 

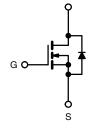


# **E Series Power MOSFET**

PRODUCT SUMMA	RY	
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650	)
R <sub>DS(on)</sub> max. at 25 °C (Ω)	$V_{GS} = 10 V$	0.125
Q <sub>g</sub> max. (nC)	130	)
Q <sub>gs</sub> (nC)	15	
Q <sub>gd</sub> (nC)	39	
Configuration	Sing	le

### **TO-220 FULLPAK**





N-Channel MOSFET

### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

## **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
  - LED lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
- · Battery chargers
- Renewable energy
  - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free and Halogen-free	SiHF30N60E-GE3
Lead (Pb)-free	SiHF30N60E-E3

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> :	= 25 °C, unle	ss otherwis	se noted)			
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	600	V		
Gate-Source Voltage			V <sub>GS</sub>	± 30	- V	
Continuous Drain Current (T <sub>1</sub> = 150 °C) <sup>d</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C		29		
Continuous Drain Current $(1_j = 150 \text{ C})^2$	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	ID	18	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	76		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	690	mJ	
Maximum Power Dissipation			P <sub>D</sub>	37	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope	V <sub>DS</sub> = 0 V to	80 % V <sub>DS</sub>	-1) / / -1+	70		
Reverse Diode dV/dt <sup>e</sup>	•		dV/dt	18	V/ns	
Soldering Recommendations (Peak temperature) <sup>c</sup>	for 10	)s		300	°C	
Mounting Torque	M3 sc	rew		0.6	Nm	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 28.2 mH,  $R_q = 25 \Omega$ ,  $I_{AS} = 7$  A.

c. 1.6 mm from case.

d. Limited by maximum junction temperature.

e.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.

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COMPLIANT HALOGEN

FREE



Vishay Siliconix

$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	THERMAL RESISTANCE RATI	NGS							
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		65			°C ///	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-		3.4			-0/w	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$									
Static         V <sub>DS</sub> V <sub>DS</sub> = 0 V, I <sub>D</sub> = 250 µA         600         -         -         V           Orain-Source Dreakdown Voltage $\Delta$ V <sub>DS</sub> /T <sub>J</sub> Reference to 25 °C, I <sub>D</sub> = 250 µA         -         0.64         -         V/r           Gate-Source Threshold Voltage (N)         V <sub>GS</sub> (m)         V <sub>DS</sub> = 250 µA         2.0         2.8         4.0         V/r           Gate-Source Leakage         I <sub>GSS</sub> V <sub>GS</sub> = ±20 V         -         -         ± 100         nA           Zero Gate Voltage Drain Current         I <sub>DSS</sub> V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V         -         -         100         µA           Drain-Source On-State Resistance         R <sub>DS(m)</sub> V <sub>SS</sub> = 10 V         I <sub>D</sub> = 15 A         -         0.104         0.125         Ω           Porward Transconductance <sup>®</sup> g <sub>16</sub> V <sub>DS</sub> = 0 V, V <sub>DS</sub> = 10 V         -         138         -           Input Capacitance         C <sub>ress</sub> V <sub>DS</sub> = 10 V, V <sub>DS</sub> = 0 V, V <sub>D</sub>									
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		SYMBOL	IES	I CONDII	IONS	MIN.	TYP.	MAX.	UNI
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						600		-	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$				-	0.64	-	V/°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	-			2.0	2.8	4.0	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Leakage	loss				-	-	± 100	nA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		1655		$V_{GS} = \pm 30$	V	-	-	± 1	μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	laaa	V <sub>DS</sub> =	= 600 V, V <sub>C</sub>	<sub>as</sub> = 0 V	-	-	1	
Forward Transconductance <sup>a</sup> $g_{fs}$ $V_{DS} = 8$ V, $l_p = 3$ A       -       5.4       -       S         Dynamic       Input Capacitance $C_{6ss}$ $V_{DS} = 100$ V, $V_{DS} = 0$ V to 480 V, $V_{GS} = 0$ V       -       2600       -       -       138       -       -       5.4       -       S         Beverse Transfer Capacitance $C_{oss}$ $V_{GS} = 0$ V, $V_{DS} = 100$ V, $V_{DS} = 0$ V       -       3       -       -       38       -       -       7.3       -       -       98       -       -       364       -       -       346       -       -       346       -       -       346       -       -       346       -       -       346       -       -       363       -       -       346       -       -       363       -       -       363       -       -       363       -       -       363       -       -       363       -       -       10       -       10       -       10       -       10       -       10       -       10       -       10       -       10       -       -       10	Zero date voltage Drain ourrent	USS	$V_{DS} = 600 V_{DS}$	/, V <sub>GS</sub> = 0 '	V, T <sub>J</sub> = 150 °C	-	-	100	μΛ
Dynamic         Job         Jo	Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I	l <sub>D</sub> = 15 A	-	0.104	0.125	Ω
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>D</sub>	<sub>S</sub> = 8 V, I <sub>D</sub>	= 3 A	-	5.4	-	S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic		•						•
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C <sub>iss</sub>		$V_{co} = 0$	1	-	2600	-	
Reverse Transfer Capacitance $C_{rss}$ $f = 1.0 \text{ MHz}$ $ 3$ $-$ Effective Output Capacitance, Energy Related a $C_{o(er)}$ $V_{DS} = 0 \text{ V}$ to $480 \text{ V}, V_{GS} = 0 \text{ V}$ $ 98$ $-$ Effective Output Capacitance, Time Related b $C_{o(tr)}$ $V_{DS} = 0 \text{ V}$ to $480 \text{ V}, V_{GS} = 0 \text{ V}$ $ 346$ $-$ Total Gate Charge $Q_g$ $Q_{gs}$ $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 85$ $130$ Gate-Drain Charge $Q_{gd}$ $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 15$ $-$ Turn-On Delay Time $t_{d(on)}$ $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 19$ $40$ Rise Time $t_r$ $V_{QS} = 10 \text{ V}, R_g = 4.7 \Omega$ $ 63$ $95$ $-$ Turn-Off Delay Time $t_d(off)$ $V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$ $ 63$ $95$ $-$ Fall Time $t_r$ $T_g$ $f = 1 \text{ MHz}, open drain 0.63 \OmegaDrain-Source Body Diode CharacteristicsP^rP^r n junction diode  29APulsed Diode Forward CurrentI_SMOSFET symbol showing the integral reverse p - n junction diode  65-Diode Forward VoltageV_{SD}T_J = 25 °C, I_S = 15 \text{ A}, V_{GS} = 0 \text{ V}  1.3 \text{ V}Body Diode Reverse Recovery Timet_{rr}T_J = 25 °C, I_F = I_S = 15 \text{ A}, dI/dt = 100 A/\mus, V_R$	Output Capacitance					-	138	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse Transfer Capacitance	C <sub>rss</sub>		f = 1.0 MH	Ηz	-	3	-	
Effective Output Capacitance, Time Related b $C_{o(tr)}$ -346-Total Gate Charge $Q_g$ Gate-Source Charge $Q_{gd}$ Gate-Drain Charge $Q_{gd}$ Tum-On Delay Time $t_{d(on)}$ Rise Time $t_r$ Tum-Off Delay Time $t_{d(off)}$ Fall Time $t_r$ Gate Input Resistance $R_g$ f = 1 MHz, open drain-0.63-Optimular Source Body Diode CharacteristicsContinuous Source-Drain Diode Current $I_S$ Num-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current $I_S$ Diode Forward Voltage $V_{SD}$ Tug = 25 °C, I_S = 15 A, V_GS = 0 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C,	Effective Output Capacitance, Energy Related <sup>a</sup>					-	98	-	pF
Gate-Source Charge $Q_{gs}$ $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ -15-nCGate-Drain Charge $Q_{gd}$ Turn-On Delay Time $t_{d(on)}$ Rise Time $t_r$ Turn-Off Delay Time $t_{d(off)}$ Fall Time $t_r$ Fall Time $t_f$ Gate Input Resistance $R_g$ $r = 1 \text{ MHz}, open drain$ - $0.63$ - $0.64$ - $0.64$ - $0.65$ - $0.65$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - $0.665$ - <td>Effective Output Capacitance, Time Related <sup>b</sup></td> <td>C<sub>o(tr)</sub></td> <td><math>V_{\rm DS} = 0</math> V</td> <td>7 to 480 V,</td> <td>V<sub>GS</sub> = 0 V</td> <td>-</td> <td>346</td> <td>-</td> <td></td>	Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	$V_{\rm DS} = 0$ V	7 to 480 V,	V <sub>GS</sub> = 0 V	-	346	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Total Gate Charge	Qq				-	85	130	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 15	A, V <sub>DS</sub> = 480 V	-	15	-	nC
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q <sub>qd</sub>				-	39	-	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time					-	19	40	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time			- 380 \/ I-	_ 15 A	-	32	65	
Fall Time $t_f$ -3675Gate Input Resistance $R_g$ $f = 1 \text{ MHz}$ , open drain-0.63- $\Omega$ Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current $I_S$ MOSFET symbol showing the integral reverse $p - n$ junction diode29APulsed Diode Forward Current $I_{SM}$ $T_J = 25 ^{\circ}C$ , $I_S = 15 \text{ A}$ , $V_{GS} = 0 \text{ V}$ 1.3VBody Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 ^{\circ}C$ , $I_F = I_S = 15 \text{ A}$ , dl/dt = 100 A/µs, $V_R = 20 \text{ V}$ -71.5µC	Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>DD</sub> =	= 10 V, R <sub>a</sub>	= 13 A, = 4.7 Ω	-	63	95	ns
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse $p - n$ junction diode29APulsed Diode Forward CurrentIsmIsmTJ = 25 °C, Is = 15 A, Vgs = 0 V65-Diode Forward VoltageVspTJ = 25 °C, Is = 15 A, Vgs = 0 V1.3VBody Diode Reverse Recovery TimetrrTJ = 25 °C, IF = Is = 15 A, 	Fall Time			. 9		-	36	75	V/°(           V/           μA           μA           Ω           S           nC           nS           Ω           Λ
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse p - n junction diode-29APulsed Diode Forward CurrentIsMIsM $T_J = 25 ^{\circ}C$ , Is = 15 A, VGS = 0 V65ADiode Forward VoltageVSD $T_J = 25 ^{\circ}C$ , Is = 15 A, VGS = 0 V1.3VBody Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 ^{\circ}C$ , IF = IS = 15 A, dI/dt = 100 A/µs, VR = 20 V-715µC	Gate Input Resistance	R <sub>q</sub>	f = 1	MHz, ope	n drain	-	0.63	-	Ω
Continuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse p - n junction diode-29APulsed Diode Forward CurrentIsMIsM $T_J = 25 \ ^{\circ}C$ , Is = 15 A, VGS = 0 V65Diode Forward VoltageVsD $T_J = 25 \ ^{\circ}C$ , Is = 15 A, VGS = 0 V1.3VBody Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 \ ^{\circ}C$ , IF = IS = 15 A, dI/dt = 100 A/µs, VR = 20 V71.5µC	Drain-Source Body Diode Characteristic	÷	•						
Pulsed Diode Forward CurrentIsmIntegral reverse p - n junction diode65Diode Forward Voltage $V_{SD}$ $T_J = 25 \ ^{\circ}C$ , $I_S = 15 \ ^{\circ}A$ , $V_{GS} = 0 \ ^{\circ}V$ 1.3 $V$ Body Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = I_S = 15 \ ^{\circ}A$ , dl/dt = 100 A/µs, $V_R = 20 \ ^{\circ}V$ 402605nsDiode Reverse Recovery Charge $Q_{rr}$ $T_J = 25 \ ^{\circ}C$ , $I_F = I_S = 15 \ ^{\circ}A$ , dl/dt = 100 A/µs, $V_R = 20 \ ^{\circ}V$ -715 $\mu C$	Continuous Source-Drain Diode Current	I <sub>S</sub>	-	bol		-	-	29	
Body Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 \ ^\circ C$ , $I_F = I_S = 15 \ A$ , $dl/dt = 100 \ A/\mu s$ , $V_R = 20 \ V$ $ 402$ $605$ $ns$ $R_{rr}$ $T_J = 25 \ ^\circ C$ , $I_F = I_S = 15 \ A$ , $dl/dt = 100 \ A/\mu s$ , $V_R = 20 \ V$ $ 7$ $15$ $\mu C$	Pulsed Diode Forward Current	I <sub>SM</sub>	integral revers			-	-	65	A
Body Diode Reverse Recovery Time $t_{rr}$ $T_J = 25 \degree C, I_F = I_S = 15 \mbox{ A}, dl/dt = 100 \mbox{ A/}\mu s, V_R = 20 \mbox{ V}$ -402605nsT_J = 25 \degree C, I_F = I_S = 15 \mbox{ A}, dl/dt = 100 \mbox{ A/}\mu s, V_R = 20 \mbox{ V}-715 $\mu C$	Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °0	C, I <sub>S</sub> = 15 /	A, V <sub>GS</sub> = 0 V	-	-	1.3	V
Body Diode Reverse Recovery Charge $Q_{rr}$ $T_J = 25 \ ^{\circ}C, I_F = I_S = 15 \ A, dI/dt = 100 \ A/\mu s, V_R = 20 \ V$ -715 $\mu C$	Body Diode Reverse Recovery Time			-		-	402	605	ns
	, ,					-			μC
	Reverse Recovery Current	I <sub>RRM</sub>	ai/at =	του A/μs,	$v_{\rm R} = 20 V$	-	32	65	A

### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{\rm DS}$  is rising from 0 % to 80 %  $V_{\rm DSS}.$ 

b. Coss(tr) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 % to 80 % VDSS.



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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

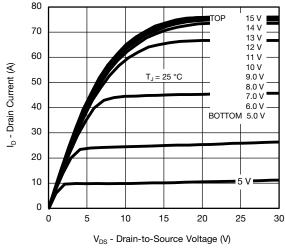
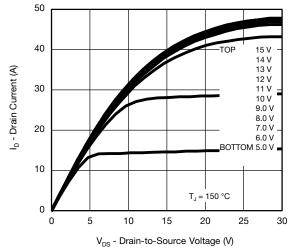
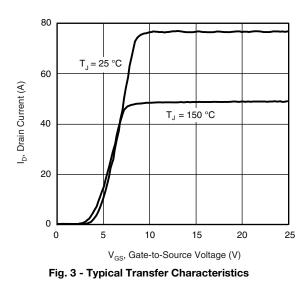


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C







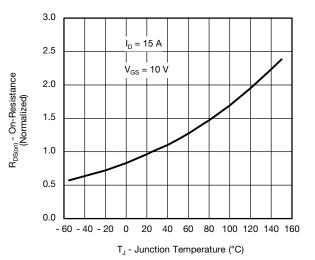


Fig. 4 - Normalized On-Resistance vs. Temperature

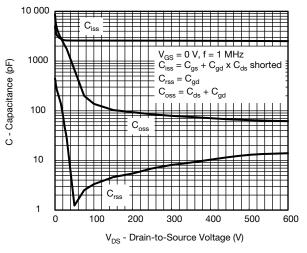
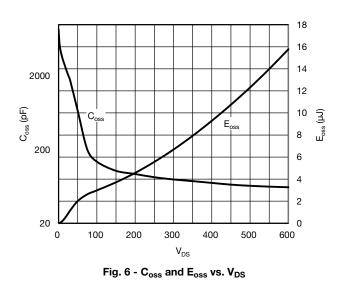


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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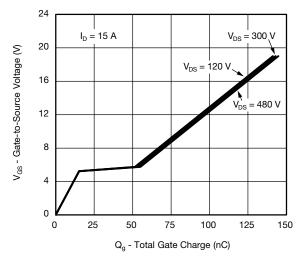
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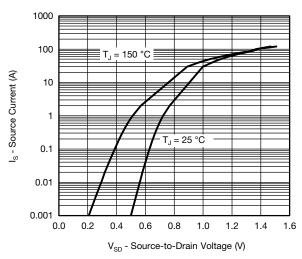
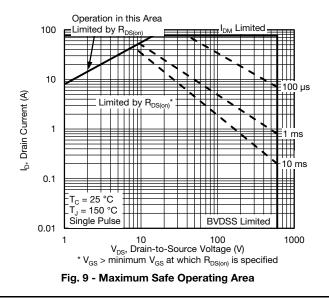


Fig. 8 - Typical Source-Drain Diode Forward Voltage



(3) 20.0 (3) 20.0 (5)

30.0

Fig. 10 - Maximum Drain Current vs. Case Temperature

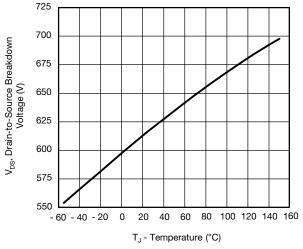


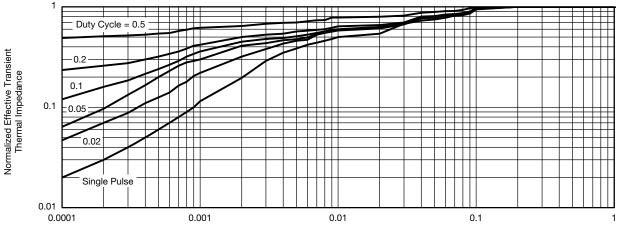
Fig. 11 - Temperature vs. Drain-to-Source Voltage

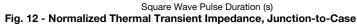
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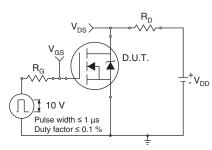


Fig. 13 - Switching Time Test Circuit

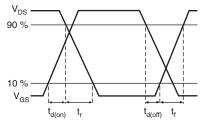


Fig. 14 - Switching Time Waveforms

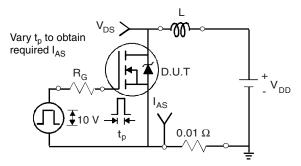


Fig. 15 - Unclamped Inductive Test Circuit

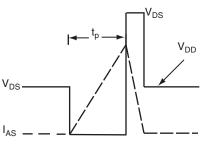


Fig. 16 - Unclamped Inductive Waveforms

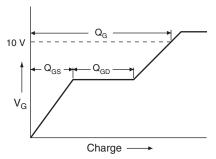
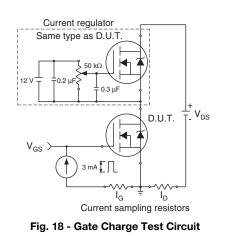


Fig. 17 - Basic Gate Charge Waveform



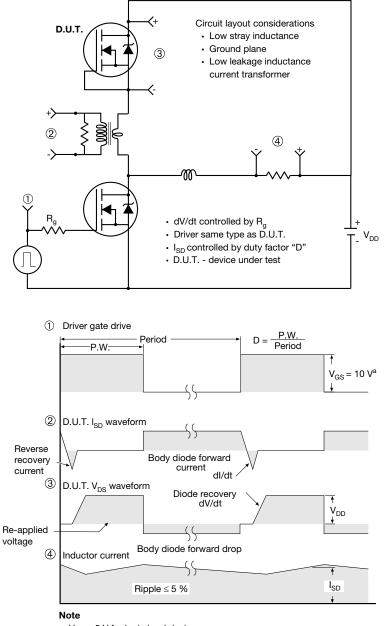
S16-1084-Rev. I, 06-Jun-16

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### Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5 V$  for logic level devices

Fig. 19 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?91454">www.vishay.com/ppg?91454</a>.

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Vishay Siliconix

# **TO-220 FULLPAK (High Voltage)**

## **OPTION 1: FACILITY CODE = 9**



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
A	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

### Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet  $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
  6. Facility code will be the 1<sup>st</sup> character located at the 2<sup>nd</sup> row of the unit marking

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## **OPTION 2: FACILITY CODE = Y**



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100	) BSC	
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

DWG: 5972

### Notes

1. To be used only for process drawing

2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads

3. All critical dimensions should C meet  $C_{pk} > 1.33$ 

4. All dimensions include burrs and plating thickness

5. No chipping or package damage
6. Facility code will be the 1<sup>st</sup> character located at the 2<sup>nd</sup> row of the unit marking

2

Document Number: 91359

For technical questions, contact: hvmos.techsupport@vishay.com

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